

CMOS Static RAM 1 Meg (128K x 8-Bit)

71024S

Features

- 128K x 8 advanced high-speed CMOS static RAM
- ◆ Commercial (0°C to +70°C), Industrial (-40°C to +85°C)
- Equal access and cycle times
 - Commercial and Industrial: 12/15/20ns
- Two Chip Selects plus one Output Enable pin
- Bidirectional inputs and outputs directly TTL-compatible
- Low power consumption via chip deselect
- Available in 300 and 400 mil Plastic SOJ.
- Industrial temperature range (-40°C to +85°C) is available for selected speeds
- Green parts available, see ordering information

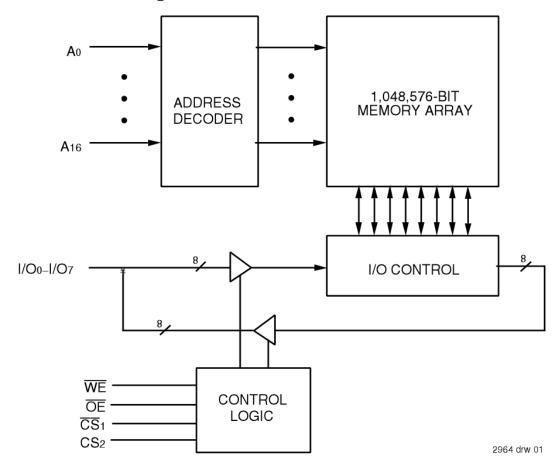
Description

The IDT71024 is a 1,048,576-bit high-speed static RAM organized as $128 \, \text{K} \, \text{x} \, 8$. It is fabricated using high-performance, high-reliability CMOS technology. This state-of-the-art technology, combined with innovative circuit design techniques, provides a cost-effective solution for high-speed memory needs.

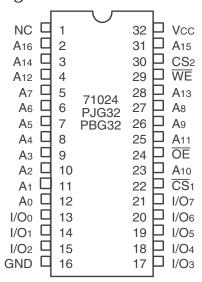
The IDT71024 has an output enable pin which operates as fast as 6ns, with address access times as fast as 12ns available. All bidirectional inputs and outputs of the IDT71024 are TTL-compatible, and operation is from a single 5V supply. Fully static asynchronous circuitry is used; no clocks or refreshes are required for operation.

The IDT71024 is packaged in 32-pin 300 mil Plastic SOJ and 32-pin 400 mil Plastic SOJ.

Functional Block Diagram



Pin Configuration⁽¹⁾



SOJ Top View 2964 drw 02

NOTE:

1. This text does not indicate orientation of actual part-marking.

Truth Table (1,3)

| Inputs | | | | | |
|--------|--------------------|--------------------|----|---------|-----------------------------|
| WE | CS ₁ | CS ₂ | ŌĒ | I/O | Function |
| Х | Н | Х | Х | High-Z | Deselected – Standby (ISB) |
| Х | VHC ⁽²⁾ | Х | Χ | High-Z | Deselected – Standby (ISB1) |
| Х | Х | L | Χ | High-Z | Deselected – Standby (ISB) |
| Х | Χ | VLC ⁽²⁾ | Χ | High-Z | Deselected – Standby (IsB1) |
| Н | L | Н | Н | High-Z | Outputs Disabled |
| Н | L | Н | L | DATAout | Read Data |
| L | L | Н | Χ | DATAIN | Write Data |

NOTES:

- 1. $H = V_{IH}, L = V_{IL}, X = Don't care.$
- 2. VLC = 0.2V, VHC = VCC 0.2V.
- 3. Other inputs \geq VHC or \leq VLC.

2964 tbl 01

Recommended Operating Temperature and Supply Voltage

| Grade | Temperature | GND | V cc | |
|------------|----------------|-----|-----------------|--|
| Commercial | 0°C to +70°C | 0V | $5.0V \pm 0.5V$ | |
| Industrial | –40°C to +85°C | 0V | 5.0V ± 0.5V | |

2964 tbl 05

Absolute Maximum Ratings(1)

| Symbol | Rating | Value | Unit |
|----------------------|--------------------------------------|--------------|------|
| VTERM ⁽²⁾ | Terminal Voltage with Respect to GND | -0.5 to +7.0 | ٧ |
| TBIAS | Temperature Under Bias | -55 to +125 | ۰C |
| Tstg | Storage Temperature | -55 to +125 | ٥C |
| Рт | Power Dissipation | 1.25 | W |
| Іоит | DC Output Current | 50 | mA |

NOTES:

2964 tbl 02

- Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause
 permanent damage to the device. This is a stress rating only and functional operation
 of the device at these or any other conditions above those indicated in the operational
 sections of this specification is not implied. Exposure to absolute maximum rating
 conditions for extended periods may affect reliability.
- 2. VTERM must not exceed Vcc + 0.5V.

Capacitance

 $(TA = +25^{\circ}C, f = 1.0MHz, SOJ package)$

| Symbol | Parameter ⁽¹⁾ | Conditions | Max. | Unit |
|--------|--------------------------|------------|------|------|
| Cin | Input Capacitance | VIN = 3dV | 7 | pF |
| Ci/o | I/O Capacitance | Vout = 3dV | 8 | pF |

2964 tbl 03

2964 tbl 04

NOTE:

1. This parameter is guaranteed by device characterization, but is not production tested.

Recommended DC Operating Conditions

| Symbol | Parameter | Min. | Тур. | Max. | Unit |
|--------|--------------------|---------------------|------|---------|------|
| Vcc | Supply Voltage | 4.5 | 5.0 | 5.5 | ٧ |
| GND | Ground | 0 | 0 | 0 | ٧ |
| VIH | Input High Voltage | 2.2 | _ | Vcc+0.5 | ٧ |
| VIL | Input Low Voltage | -0.5 ⁽¹⁾ | _ | 0.8 | V |

NOTE:

1. V_{IL} (min.) = -1.5V for pulse width less than 10ns, once per cycle.

DC Electrical Characteristics

(Vcc = 5.0V ± 10%, Commercial and Industrial Temperature Ranges)

| | | | IDT7 | | |
|--------|------------------------|--|------|------|------|
| Symbol | Parameter | Test Condition | Min. | Max. | Unit |
| 111 | Input Leakage Current | Vcc = Max., Vin = GND to Vcc | - | 5 | μΑ |
| lLO | Output Leakage Current | Vcc = Max., $\overline{\text{CS}}_1$ = V _{IH} , Vout = GND to Vcc | _ | 5 | μA |
| Vol | Output Low Voltage | IoL = 8mA, Vcc = Min. | - | 0.4 | ٧ |
| Vон | Output High Voltage | Iон = -4mA, Vcc = Min. | 2.4 | _ | V |

2964 tbl 06

DC Electrical Characteristics(1)

 $(VCC = 5.0V \pm 10\%, VLC = 0.2V, VHC = VCC - 0.2V)$

| | | 71024S12 | | 71024S15 | | 71024S20 | | | |
|--------|--|----------|------|----------|------|----------|------|------|--|
| Symbol | Parameters | Com'l. | Ind. | Com'l. | Ind. | Com'l. | Ind. | Unit | |
| Icc | Dynamic Operating Current, $CS_2 \ge V_{IH}$ and $\overline{CS}_1 \le V_{IL}$, Outputs Open, $VCC = Max.$, $f = f_{MAX}^{(2)}$ | 160 | 160 | 155 | 155 | 140 | 140 | mA | |
| ISB | Standby Power Supply Current (TTL Level) $\overline{CS}_1 \ge V_{IH}$ or $CS_2 \le V_{IL}$, Outputs Open, $Vcc = Max.$, $f=f_{Max}^{(2)}$ | 40 | 40 | 40 | 40 | 40 | 40 | mA | |
| ISB1 | Full Standby Power Supply Current (CMOS Level), $\overline{CS}_1 \ge V$ HC or $CS_2 \le V$ LC, Outputs Open, V CC = Max., $f = 0^{(2)}$, V IN $\le V$ LC or V IN $\ge V$ HC | 10 | 10 | 10 | 10 | 10 | 10 | mA | |

NOTES:

- 1. All values are maximum guaranteed values.
- fMAX = 1/trc (all address inputs are cycling at fMAX): f = 0 means no address input lines are changing.

AC Test Conditions

| Input Pulse Levels | GND to 3.0V |
|-------------------------------|---------------------|
| Input Rise/Fall Times | 3ns |
| Input Timing Reference Levels | 1.5V |
| Output Reference Levels | 1.5V |
| AC Test Load | See Figures 1 and 2 |

2964 tbl 08

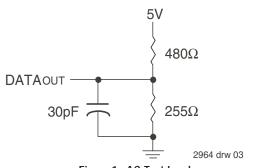
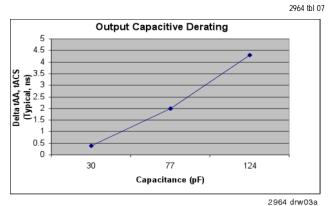


Figure 1. AC Test Load



DATAOUT 480Ω $5pF^*$ 255Ω 2964 drw 04

*Including jig and scope capacitance.

Figure 2. AC Test Load (for tclz, tolz, tchz, tohz, tow, and twhz)

AC Electrical Characteristics

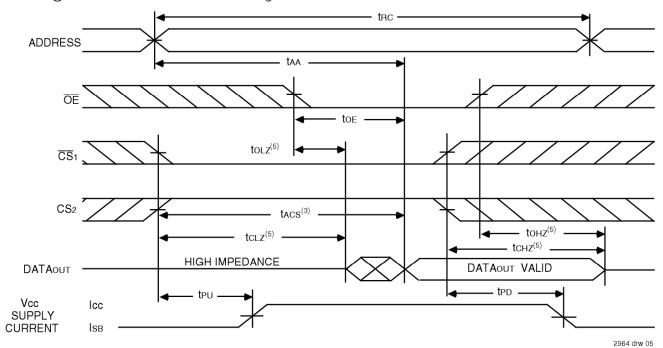
(Vcc = 5.0V ± 10%, Commercial and Industrial Temperature Ranges)

| | | 7102 | 24S12 | 71024S15 | | 71024S20 | | |
|---------------------|------------------------------------|------|-------|----------|------|----------|------|------|
| Symbol | Parameter | Min. | Max. | Min. | Max. | Min. | Max. | Unit |
| Read Cycle | | • | • | • | • | • | | |
| trc | Read Cycle Time | 12 | _ | 15 | _ | 20 | _ | ns |
| taa | Address Access Time | _ | 12 | _ | 15 | _ | 20 | ns |
| tacs | Chip Select Access Time | _ | 12 | _ | 15 | _ | 20 | ns |
| tclz ⁽¹⁾ | Chip Select to Output in Low-Z | 3 | _ | 3 | _ | 3 | _ | ns |
| tcHz ⁽¹⁾ | Chip Deselect to Output in High-Z | 0 | 6 | 0 | 7 | 0 | 8 | ns |
| toe | Output Enable to Output Valid | _ | 6 | _ | 7 | _ | 8 | ns |
| tolz ⁽¹⁾ | Output Enable to Output in Low-Z | 0 | _ | 0 | _ | 0 | _ | ns |
| tonz ⁽¹⁾ | Output Disable to Output in High-Z | 0 | 5 | 0 | 5 | 0 | 7 | ns |
| tон | Output Hold from Address Change | 4 | _ | 4 | _ | 4 | _ | ns |
| tpu ⁽¹⁾ | Chip Select to Power-Up Time | 0 | _ | 0 | _ | 0 | _ | ns |
| tPD ⁽¹⁾ | Chip Deselect to Power-Down Time | _ | 12 | _ | 15 | _ | 20 | ns |
| Write Cycle | | | | | | | | |
| twc | Write Cycle Time | 12 | _ | 15 | _ | 20 | _ | ns |
| taw | Address Valid to End-of-Write | 10 | _ | 12 | _ | 15 | - | ns |
| tcw | Chip Select to End-of-Write | 10 | _ | 12 | _ | 15 | _ | ns |
| tas | Address Set-Up Time | 0 | _ | 0 | _ | 0 | _ | ns |
| twp | Write Pulse Width | 8 | _ | 12 | _ | 15 | _ | ns |
| twr | Write Recovery Time | 0 | _ | 0 | _ | 0 | _ | ns |
| tow | Data Valid to End-of-Write | 7 | _ | 8 | _ | 9 | - | ns |
| tDH | Data Hold Time | 0 | _ | 0 | _ | 0 | _ | ns |
| tow ⁽¹⁾ | Output Active from End-of-Write | 3 | _ | 3 | _ | 4 | - | ns |
| twHz ⁽¹⁾ | Write Enable to Output in High-Z | 0 | 5 | 0 | 5 | 0 | 8 | ns |

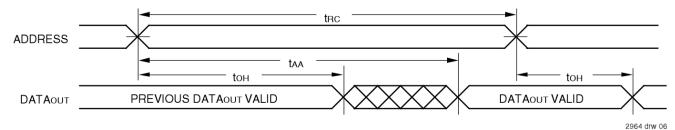
NOTE: 2964 tbl 09

 $^{1. \}quad \text{This parameter guaranteed with the AC load (Figure 2) by device characterization, but is not production tested.} \\$

Timing Waveform of Read Cycle No. 1(1)



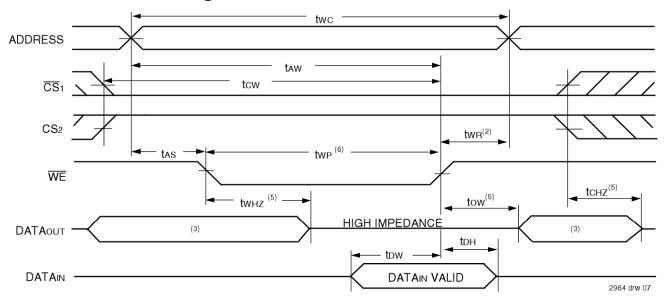
Timing Waveform of Read Cycle No. 2(1,2,4)



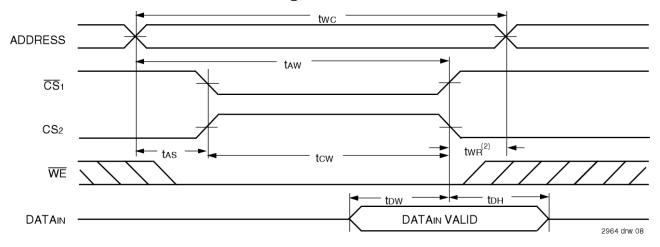
NOTES:

- 1. WE is HIGH for Read Cycle.
- 2. Device is continuously selected, $\overline{\text{CS}}_1$ is LOW, CS2 is HIGH.
- 3. Address must be valid prior to or coincident with the later of \overline{CS}_1 transition LOW and CS2 transition HIGH; otherwise tAA is the limiting parameter.
- 4. $\overline{\mathsf{OE}}\mathsf{isLOW}.$
- 5. Transition is measured ±200mV from steady state.

Timing Waveform of Write Cycle No. 1 (**WE** Controlled Timing)^(1,4,6)



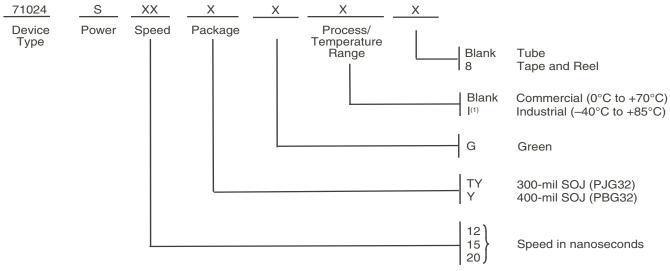
Timing Waveform of Write Cycle No. 2 (**CS**₁ AND CS₂ Controlled Timing)^(1,4)



NOTES:

- 1. A write occurs during the overlap of a LOW \overline{CS}_1 , HIGH CS₂, and a LOW \overline{WE} .
- 2. twn is measured from the earlier of either $\overline{\text{CS}}_1$ or $\overline{\text{WE}}$ going HIGH or CS2 going LOW to the end of the write cycle.
- 3. During this period, I/O pins are in the output state, and input signals must not be applied.
- 4. If the CS1 LOW transition or the CS2 HIGH transition occurs simultaneously with or after the WE LOW transition, the outputs remain in a high impedance state. CS1 and CS2 must both be active during the tcw write period.
- 5. <u>Transition is measured ±200mV from steady state</u>.
- 6. \overline{OE} is continuously HIGH. During a \overline{WE} controlled write cycle with \overline{OE} LOW, twp must be greater than or equal to twHz + tbw to allow the I/O drivers to turn off and data to be placed on the bus for the required tbw. If \overline{OE} is HIGH during a \overline{WE} controlled write cycle, this requirement does not apply and the minimum write pulse is the specified twp.

Ordering Information



NOTE:

2964 drw 09

Orderable Part Information

| Speed (ns) | Orderable Part ID | Pkg. Code | Pkg. Type | Temp. Grade |
|---------------|-------------------|--------------|--------------|----------------|
| 12 | 71024S12TYG | PJG32 | SOJ | С |
| | 71024S12TYG8 | PJG32 | SOJ | С |
| | 71024S12TYGI | PJG32 | SOJ | I |
| | 71024S12TYGl8 | PJG32 | SOJ | I |
| | 71024S12YG | PBG32 | SOJ | С |
| | 71024S12YG8 | PBG32 | SOJ | С |
| | 71024S12YGI | PBG32 | SOJ | - |
| | 71024S12YGl8 | PBG32 | SOJ | - |
| 15 | 71024S15TYG | PJG32 | SOJ | С |
| | 71024S15TYG8 | PJG32 | SOJ | С |
| | 71024S15TYGI | PJG32 | SOJ | _ |
| | 71024S15TYGl8 | PJG32 | SOJ | _ |
| | 71024S15YG | PBG32 | SOJ | С |
| | 71024S15YG8 | PBG32 | SOJ | С |
| | 71024S15YGI | PBG32 | SOJ | _ |
| | 71024S15YGl8 | PBG32 | SOJ | - |
| 20 | 71024S20TYG | PJG32 | SOJ | С |
| | 71024S20TYG8 | PJG32 | SOJ | С |
| | 71024S20TYGI | PJG32 | SOJ | _ |
| | 71024S20TYGI8 | PJG32 | SOJ | - |
| | 71024S20YG | PBG32 | SOJ | С |
| | 71024S20YG8 | PBG32 | SOJ | С |
| | 71024S20YGI | PBG32 | SOJ | I |
| | 71024S20YGl8 | PBG32 | SOJ | Ι |

^{1.} Contact your local sales office for Industrial temp range for other speeds, packages and powers.

Datasheet Document History

| 9/30/99 | | Updated to new format |
|----------|----------------|--|
| | Pg. 1, 3, 4, 7 | Added 12ns industrial speed grade offering |
| | Pg. 1–4, 7 | Removed military temperature offerings |
| | | Removed 17ns and 25ns speed grades |
| | Pg. 3 | Revised Icc and IsB1 for 15ns and 20ns industrial speed grades |
| | Pg. 6 | Removed Note 1, reordered notes and footnotes |
| | Pg. 8 | Added Datasheet Document History |
| 1/6/2000 | Pg. 4 | Changed twp(min) for 12ns speed grade from 10ns to 8ns. |
| 2/18/00 | Pg. 3 | Revised Icc and IsB for Industrial Temperature offerings to meet commercial specifications |
| 3/14/00 | Pg. 3 | Revised IsB to accommodate speed functionality |
| 08/09/00 | | Notrecommended for new designs |
| 02/01/01 | | Removed "Not recommended for new designs" |
| 01/30/04 | Pg. 7 | Added "Restricted hazardous substance device" to the ordering information. |
| 05/22/06 | Pg.3 | Added drawing Output Capacitive Derating drawing. |
| 02/13/07 | Pg.7 | Added M generation die step to data sheet ordering information. |
| 08/13/09 | Pg.2 | Corrected note reference. |
| 02/05/13 | Pg.1 | Removed /MS from datasheet header. Removed IDT's reference to fabrication. |
| | Pg.7 | Updated ordering information by adding Tape and Reel, updated Restricted Hazardous Substance |
| | | Device wording to Green and removed the Die Stepping Revision, the "M" designator. |
| 03/30/21 | Pg.1 & 7 | Updated Industrial temp and green availability |
| | Pg.2 & 7 | Updated package codes |
| | Pg.7 | Added Orderable Part Information table |

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